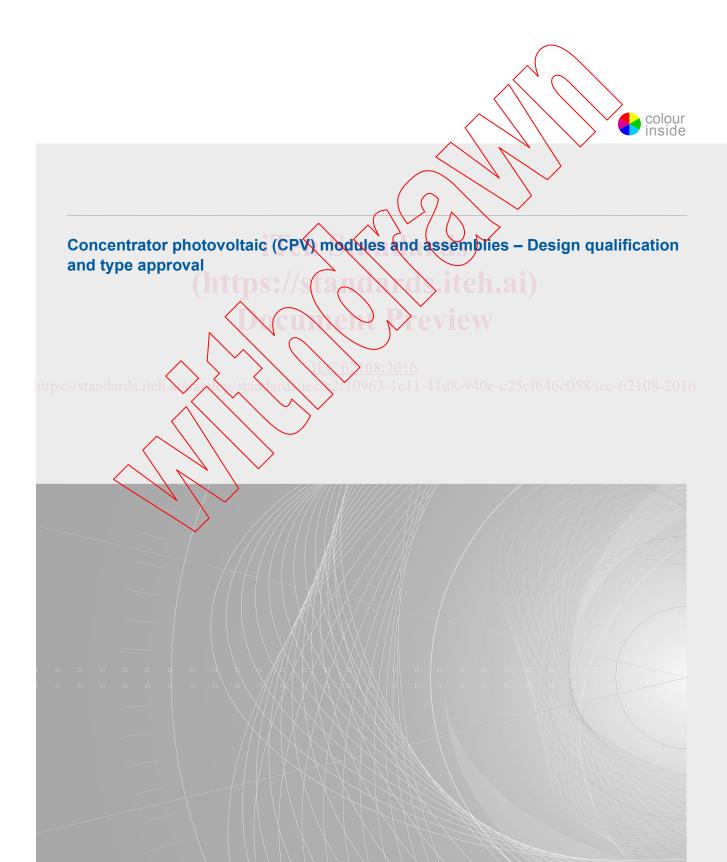


Edition 2.0 2016-09 REDLINE VERSION

INTERNATIONAL STANDARD





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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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CONTENTS

FOREWORD	5
1 Scope and object	7
2 Normative references	7
3 Terms and definitions	8
4 Sampling	9
5 Marking	
6 Testing	
	11
	19
^ \ \ \ \ \	20
10 Test procedures	20
	20
	20
10.1.2 Procedure	20
10.1.2 Procedure 10.1.3 Major visual defects 10.1.4 Requirements 10.2 Electrical performance measurement	21
10.1.4 Requirements	21
10.2 Electrical performance measurement	21
10.2.1 Purpose	21
10.2.2 Outdoor side-by-side I-V measurement	
10.2.3 Solar simulator I-V measurement	23
10.2.4 Dark I-V measurement	23
10.3 Ground path continuity test	24
10.3.1 General	24
10.3.2 Purpose	24
10.3.3 Procedure	
10.3.4 Requirements	
10.4 Electrical insulation test	
10.4.1 Purpose	
10.4.2 Procedure	
10.4.3 Requirements	25
10.5 Wet insulation test	
10.5.1 Purpose	
10.5.2 Procedure	
10.5.3 Requirements	
10.6 Thermal cycling test	
10.6.1 Purpose	
10.6.2 Test sample	
10.6.3 Procedure	
10.6.4 Requirements	
10.7 Damp heat test	
10.7.1 Purpose	
10.7.2 Test sample	
10.7.3 Procedure	
10.7.4 Requirements	
10.8 Humidity freeze test	

10.8.1	Purpose	30
10.8.2	Test sample	30
10.8.3	Procedure	31
10.8.4	Requirements	31
10.9 Hail	impact test	32
10.9.1	Purpose	32
10.9.2	Apparatus	32
10.9.3	Procedure	33
10.9.4	Requirements	33
10.10 Wat	ter spray test	33
10.10.1	General	33
10.10.2	Purpose	33
10.10.3	Procedure	34
10.10.4	Requirements	34
10.11 Byp	ass/blocking diode thermal test	34
10.11.1	Purpose	34
10.11.2	Test sample	35
10.11.3	Apparatus	35
10.11.4	Procedure	35
10.11.5	Requirements	36
10.11.6	Procedure 2 – Alternate method	36
10.12 Rob	oustness of terminations test	
10.12.1	Purpose	37
10.12.2	Types of terminations	37
10.12.3	Procedure	38
10.12.4	Requirements	38
10.13 Med	chapical load test	39
ttps://sta10.13.1.it	Purpose	
10.13.2	Procedure	40
10.13.3	Requirements	40
(axis beam damage test	
10.14.1	General	
10.44.2	Rurpose	40
10.14.3	Special case	40
10.14.4	Procedure	40
10.14.5	Requirements	
10.15 Ultr	aviolet conditioning test	
	Purpose	
	Procedure	1
10.15 Out	door exposure test	41
10.15.1	Purpose	
10.15.2	Procedure	
10.15.3	Requirements	
	-spot endurance test	
10.17 Dus	t ingress protection test	
10.17.1	Purpose	
10.17.2	Procedure	
10.17.3	Requirements	1
Anney A (info	mative) Summary of test conditions and requirements	44

	Annex B	(normative) Retesting guideline	47
	B.1	Product or process modifications requiring limited retesting to maintain certification	47
	B.2	Modifications of CPV cell technology	47
	B.3	Modifications in optical encapsulation on the cell (Includes optical coupling between the cell and a glass secondary optical element bonded to the cell)	48
	B.4	Modification in cell encapsulation outside of intended light path	48
	B.5	Modification of cell package substrate used for heat transfer	48
	B.6	Accessible optics (primary or secondary)	49
	B.7	Inaccessible optics (secondary)	
	B.8	Frame and/or mounting structure	49
	B.9	Enclosure	50
	B.10		50
	B.11	Interconnection terminals	
	B.12	Interconnection materials or technique (to cells and between receivers)	
	B.13	Change in electrical circuit design in an identical package	
	B.14	Output power	51
	B.15	Thermal energy transfer means	52
	B.16	Adhesives	52
	Bibliogra	phy	
	Figure 1	- Schematic of point-focus dish RV concentrator	13
		- Schematic of linear-focus trough RV concentrator	
		- Schematic of point-focus freshel lens\PV concentrator	
	-	- Schematic of linear-focus fresnellens PV concentrator	
	-	- Schematic of a heliostat CPV	
	•	- Qualification test sequence for SPV modules	
	Figure 7	- Qualification test sequence for CPV assemblies	2108-2 19
	-	- Temperature and current profile of thermal cycle test (not to scale)	
	_	- Profile of humidity-freeze test conditions	
	_	O Bypass diode thermal test	
	/ iguro / ·		
	Table 1 -	- Terms used for CPVs	9
•	Table 2 -	- Allocation of test samples to typical test sequences	11
	Table 3 -	- Thermal cycle test options for sequence A	29
	Table 4	- Pre-thermal cycle test options for sequence B	
		- Humidity freeze test options for sequence B	
		- Minimum wind loads	
		1 – Summary of test conditions and requirements	
		·	

INTERNATIONAL ELECTROTECHNICAL COMMISSION

CONCENTRATOR PHOTOVOLTAIC (CPV) MODULES AND ASSEMBLIES – DESIGN QUALIFICATION AND TYPE APPROVAL

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International Standard IEC 62108 has been prepared by IEC technical committee 82: Solar photovoltaic energy systems.

This second edition cancels and replaces the first edition, issued in 2007. It constitutes a technical revision.

The main technical changes with regard to the previous edition are as follows:

- a) Changes in outdoor exposure from 1000 h to 500 h.
- b) Changes in current cycling during thermal cycling test.
- c) Added dust ingress test.
- d) Eliminated thermal cycling associated with damp heat test.
- e) Eliminated UV exposure test.

The text of this standard is based on the following documents:

FDIS	Report on voting
82/1142/FDIS	82/1161/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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CONCENTRATOR PHOTOVOLTAIC (CPV) MODULES AND ASSEMBLIES – DESIGN QUALIFICATION AND TYPE APPROVAL

1 Scope and object

This International Standard specifies the minimum requirements for the design qualification and type approval of concentrator photovoltaic (CPV) modules and assemblies suitable for long-term operation in general open-air climates as defined in IEC 60721-2-1. The test sequence is partially based on that specified in IEC 61215-1 for the design qualification and type approval of flat-plate terrestrial crystalline silicon PV modules. However, some changes have been made to account for the special features of CPV receivers and modules, particularly with regard to the separation of on-site and in-lab tests, effects of tracking alignment, high current density, and rapid temperature changes, which have resulted in the formulation of some new test procedures or new requirements.

The object of this test standard is to determine the electrical, mechanical, and thermal characteristics of the CPV modules and assemblies and to show, as far as possible within reasonable constraints of cost and time, that the CPV modules and assemblies are capable of withstanding prolonged exposure in climates described in the scope. The actual life of CPV modules and assemblies so qualified will depend on their design, production, environment, and the conditions under which they are operated.

This standard shall be used in conjunction with the retest guidelines described in Annex B.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068-2-21:2006, Environmental testing – Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices

IEC 60529, Degrees of protection provided by enclosures (IP Code)

IEC 61215:2005, Crystalline silicon Terrestrial photovoltaic (PV) modules Design qualification and type approval

IEC 61215-2:2016, Terrestrial photovoltaic (PV) modules – Design qualification and type approval – Part 2: Test procedures

IEC 62670-1, Photovoltaic concentrators (CPV) – Performance testing – Part 1: Standard conditions

ISO/IEC 17025:2005, General requirements for the competence of testing and calibration laboratories

ANSI/UL 1703:2002-ed.3 March 15, Standard for Safety: Flat-Plate Photovoltaic Modules and Panels

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply. See also Table 1.

3.1

concentrator

term associated with photovoltaic devices that use concentrated sunlight

3.2

concentrator cell

basic photovoltaic device that is used under the illumination of concentrated sunlight

3.3

concentrator optics

optical device that performs one or more of the following functions from its input to output: increasing the light intensity, filtering the spectrum, modifying light intensity distribution, or changing light direction. Typically, it is a lens or a mirror

Note 1 to entry: A primary optics receives unconcentrated sunlight directly from the sun. A secondary optics receives concentrated or modified sunlight from another optical device, such as primary optics or another secondary optics.

3.4

concentrator receiver

group of one or more concentrator cells and secondary optics (if present) that accepts concentrated sunlight and incorporates the means for thermal and electric energy transfer. A receiver could be made of several sub-receivers. The sub-receiver is a physically stand-alone, smaller portion of the full-size receiver

3.5

concentrator module

group of receivers, optics, and other related components, such as interconnection and mounting, that accepts unconcentrated sunlight. All above components are usually prefabricated as one unit, and the focus point is not field adjustable. 25e1646c058/iec-62108-2016

Note 1 to entry: A module could be made of several sub-modules. The sub-module is a physically stand-alone, smaller portion of the full-size module.

3.6

concentrator assembly

group of receivers, optics, and other related components, such as interconnection and mounting, that accepts unconcentrated sunlight. All above components would usually be shipped separately and need some field installation, and the focus point is field adjustable

Note 1 to entry: An assembly could be made of several sub-assemblies. The sub-assembly is a physically standalone, smaller portion of the full-size assembly.

3.7

representative samples for CPV

see details in Clause 4

3.7

control unit

hardware that is not stressed, but is included in each measurement to enable greater confidence in consistent measurements

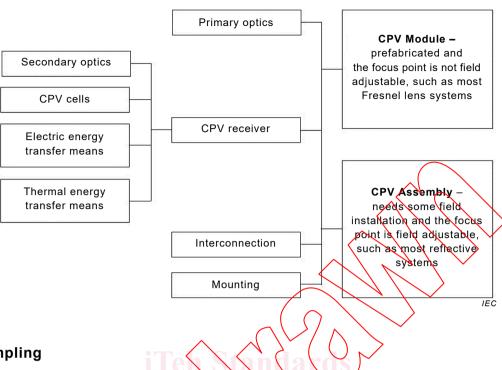


Table 1 - Terms used for CPVs

4 Sampling

Figures 1 to 5 are schematics of cells, receivers, modules, and assemblies.

For non-field-adjustable focus-point CPV systems of modules, 7 modules and 2 receivers are required to complete all the specified tests, plus one receiver for the bypass/blocking diode thermal test (intrusive or non-intrusive). For details, see Figure 6. For field-adjustable focus-point CPV systems or assemblies, 9 receivers (including secondary optics sections, if applicable) and 7 primary optics sections are required to complete all the specified tests, plus one receiver for the bypass/blocking diode thermal test (intrusive or non-intrusive). For details, see Figure 7.

In the case that a full-size module or assembly is too large to fit into available testing equipment, such as environmental chambers, or a full-size module or assembly is too expensive (e.g., for a 20 kW reflective dish concentrator system, 9 receiver samples account for 180 kW of PV cells), a smaller representative sample may can be used. However, even if representative samples are used for the other test, a full-size module or assembly shall be installed and tested for outdoor exposure. This can be conducted either in the testing lab, or through on-site witness.

Representative samples—should shall include all components, except some repeated parts. If possible, the representative samples—should shall use sub-receivers, sub-modules, or sub-assemblies. During the design and manufacturing of the representative samples, much attention—should shall be paid to reach the maximum similarity to the full-size component in all electrical, mechanical, and thermal characteristics related to quality and reliability.

Specifically, the cell string in representative samples should shall be long enough to include at least two bypass diodes, but in no case less than ten cells. The encapsulations, interconnects, terminations, and the clearance distances around all edges should shall be the same as on the actual full-size products. Other representative components, including lens/housing joints, receiver/housing joints, and end plate/lens should shall also be included and tested.

Test samples should be taken at random from a production batch or batches. When the samples to be tested are prototypes of a new design and not from production, or representative samples are used, these facts should be noted in the test report (see Clause 8).

The test samples—should shall have been manufactured from specified materials and components in accordance with the relevant drawings and process instructions and should have been subjected to the manufacturer's normal inspection, quality control, and production acceptance procedures. They—should shall be complete in every detail and should be accompanied by the manufacturer's handling, mounting, connection, and operation manuals. Samples—should shall not be subjected to other special procedures that are not a part of standard production.

If the intrusive bypass/blocking diode thermal test is to be performed, an additional specially manufactured receiver is required with extra electrical and thermal detector leads so that each individual diode can be accessed separately.

5 Marking

Each receiver or module section should shall carry the following slear and indelible markings:

- Name, monogram, or symbol of manufacturer.
- Type or model number.
- Serial number.
- Polarity of terminals or leads (color coding is permissible).
- Maximum system voltage for which the module or assembly is suitable.
- Nominal maximum output power and its tolerance at specified condition.
- The date, place of manufacture, and cell materials should shall be marked, or be traceable from the serial number.

If representative samples are used, the same markings as on full-size products should be included for all tests, and the marking should be capable of surviving all test sequences.

6 Testing

If recommended by the manufacturer, before beginning the testing, all testing samples, including the control module and control receiver, should shall be exposed to the direct normal irradiation (DNI) of sunlight (either natural or simulated) for a total of 5 kWh/m 2 to 5,5 kWh/m 2 while open circuited. This procedure is designed to reduce the initial photon degradation effects

In this standard all references to short-circuit current $I_{\rm sc}$, open-circuit voltage $V_{\rm oc}$, maximum output power $P_{\rm m}$, and other measures are all based on DNI 900 W/m², cell temperature 25 °C, spectrum at Air Mass 1,5D (under consideration), and wind speed 3 m/s Concentrator Standard Test Condition (CSTC), which is defined in IEC 62670-1. A formal Concentrator Standard Test Condition (CSTC) definition will be given in a future IEC CPV standard, which is under consideration. Alternatively, Concentrator Standard Operating Conditions (CSOC), as defined in IEC 62670-1, may be used consistently.

The test samples—should shall be randomly divided into groups and subjected to the qualification test sequences in Figure 6 or Figure 7. Test procedures and requirements are detailed in Clause 10, and summarized in Annex A. The allocation of test samples to typical test sequences is given in Table 2.

After initial tests and inspections, one module or one receiver/mirror section-should shall be removed from the test sequence as a control unit. Preferably, the control unit should be

stored in the dark at room temperature to reduce the electrical performance degradation, but it may be kept outdoors with a dark cover. As shown in Figure 6 for modules or in Figure 7 for assemblies, the test sequence is performed both in-lab and on-site. If the CPV receiver uses crystalline silicon, a 1-sun measurement (flash or outdoor) can be used as a diagnostic tool throughout the program. If the distance between these two locations is considerable or public shipping companies are involved, a dark current-voltage (I-V) curve measurement before and after the shipping should be performed to evaluate any possible changes on testing samples.

If a particular manufacturer produces only specific components, such as receivers, lenses, or mirrors, the design qualification and type approval testing—may can be conducted only on applicable test sequences, and a partial certification can be issued independently.

If some test procedures in this standard are not applicable to a specific design configuration, the manufacturer should discuss this with the certifying body and testing agency to develop a comparable test program, based on the principles described in this standard. Any changes and deviations shall be recorded and reported in details, as required in Clause 8).

Test	Me	odule	Assei	pbly
sequence	receiver	module	receiver	mirror
Control		1	1	1
Α	2	$\wedge \wedge \rangle \langle$		
В	116	2	2	2
С	(https://	2	2	2
D	(urth2.\\\	1	itemai)	1
Е		1 (full-size)	1 (full-size)	1 (full-size)
F	11		1	
Total	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	7	10	7

Table 2 - Allocation of test samples to typical test sequences

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7 Pass criteria

A concentrator photovoltaic module or assembly design—should shall be judged to have passed the qualification tests, and therefore to be IEC 62108 type approved, if each test sample meets all the following criteria:

- a) The relative power degradation in sequence A to D does not exceed 13 % if the I-V measurement is under outdoor natural sunlight, or 8 % if the I-V measurement is under solar simulator.
- b) The relative power degradation in sequence E does not exceed 7 % for natural sunlight I-V measurement, or 5 % for solar simulator I-V measurement, because the 1 000 kWh/m² DNI outdoor exposure and 50 kWh/m² ultraviolet (UV) tests are is not an accelerated stress test.
- c) No sample has exhibited any open circuit during the tests.
- d) There is no visual evidence of a major defect, as defined in 10.1.2.
- e) The insulation test requirements are met at the beginning and the end of each sequence.
- f) The wet leakage current test requirements are met at the beginning and the end of each sequence.
- g) Specific requirements of the individual tests are met.

If there are some failures observed during the test, the following judgment and re-test procedure-should shall apply:

- h) If two or more test samples do not meet pass criteria, the design shall be deemed not to have met the qualification requirements.
- i) Should one sample fail any test, another two samples meeting the requirements of Clause 4 could be subjected to the whole of the relevant test sequence from the beginning.
- j) In case i), if both samples pass the test sequence, the design-should shall be judged to have met the qualification requirements.
 - k) In case i), if one or both of these samples also fail, the design shall be deemed not to have met the qualification requirements.
- I) In case h) or k), the entire test program illustrated in Figure 6 or Figure 7-should shall be re-performed, usually after some design or processing improvement.

